

University Physics 227N/232N

Interference and Diffraction

Optional review session next Monday (Apr 28)
Bring Homework Notebooks to Final for Grading

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Friday, April 25 2014

Happy Birthday to DeAngelo Williams, Renee Zellweger, Al Pacino,
 Meadowlark Lemon, Ella Fitzgerald, and Wolfgang Pauli (1945 Nobel)!



Jefferson Lab

Prof. Satogata / Spring 2014 ODU University Physics 227N/232N 1



Review: Double-Slit Interference

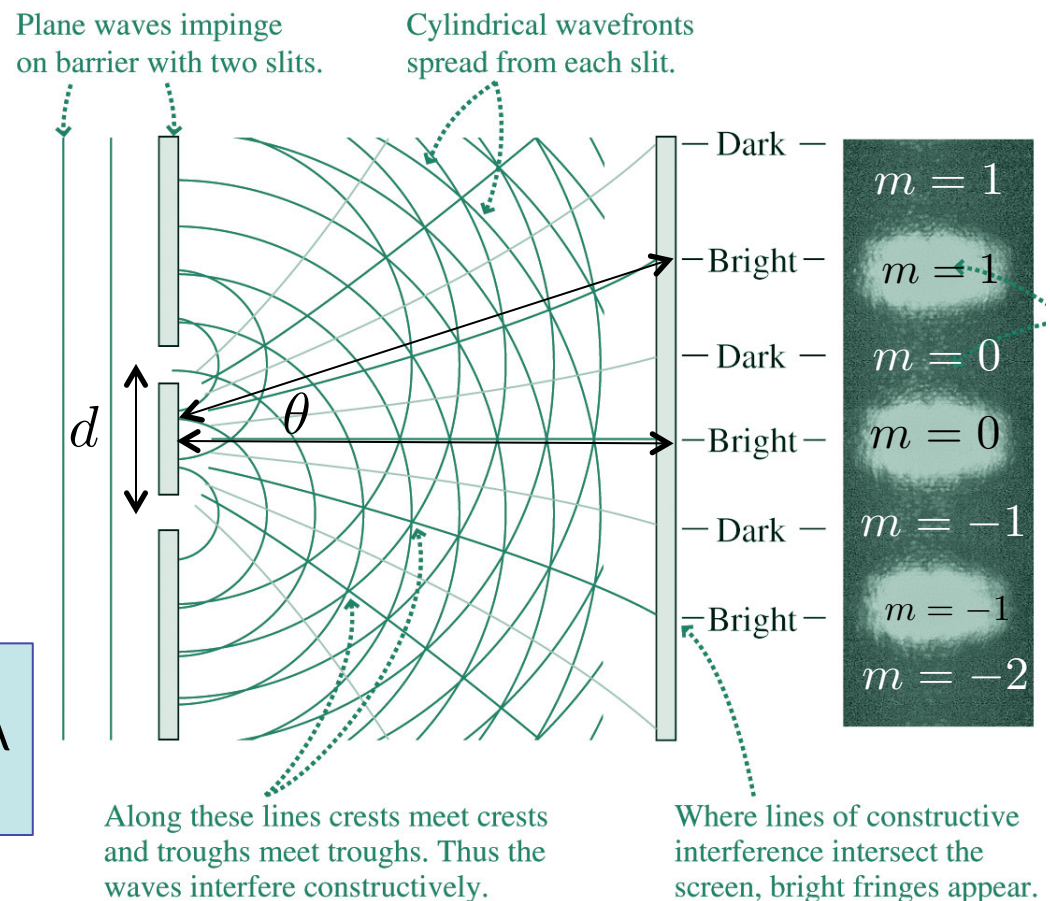
- Interference from two coherent sources produces a pattern of light and dark **interference fringes**
- A convenient way to produce the two sources is to pass light from a single source through two narrow slits.
- Positions of bright fringes are given by

$$d \sin \theta_{\text{bright}} = m\lambda$$

where m is the m^{th} fringe, and λ is the wavelength.

- Dark fringes occur where

$$d \sin \theta_{\text{dark}} = \left(m + \frac{1}{2}\right) \lambda$$



Trig Happy

- We can also calculate the distances between fringes as measured on the screen

$$\tan \theta = \frac{x}{L} \Rightarrow \sin \theta \approx \frac{x}{L}$$

Small-angle approximation for $x \ll L$!!

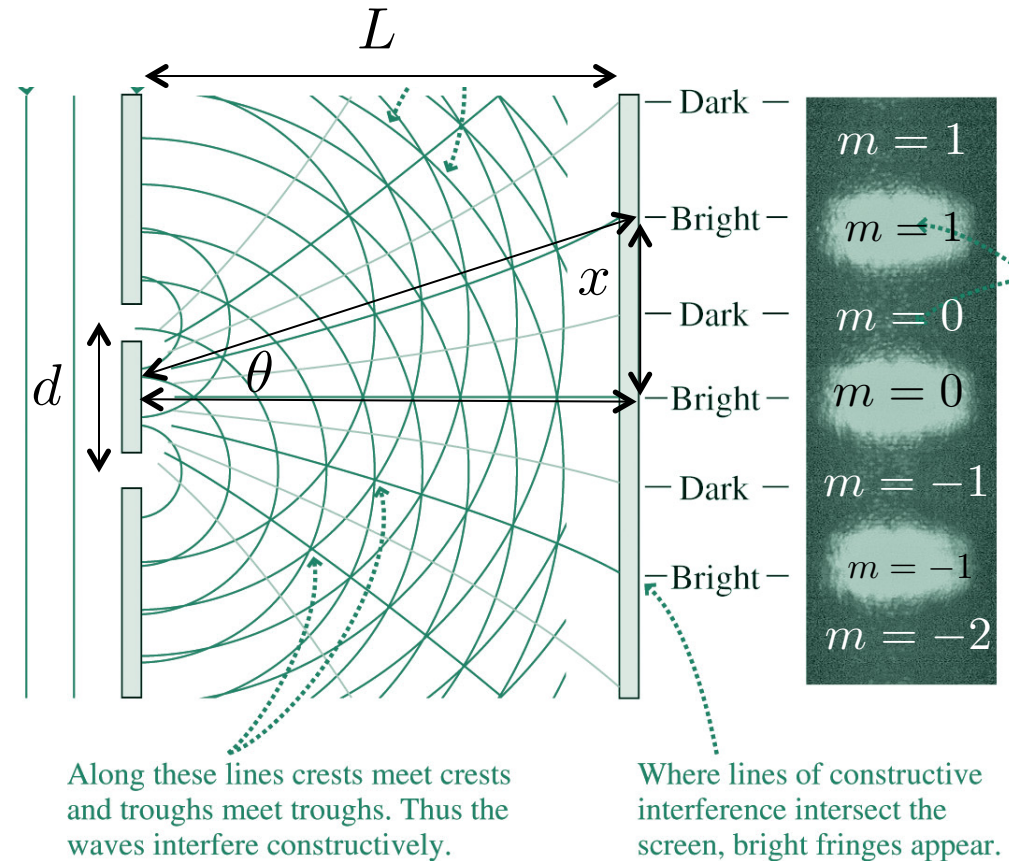
$$\sin \theta = \frac{x}{\sqrt{x^2 + L^2}}$$

$$d \sin \theta_{\text{bright}} = m\lambda$$

$$x_{\text{bright}} = \frac{m\lambda L}{d}$$

$$d \sin \theta_{\text{dark}} = \left(m + \frac{1}{2}\right) \lambda$$

$$x_{\text{dark}} = \frac{\left(m + \frac{1}{2}\right) \lambda L}{d}$$

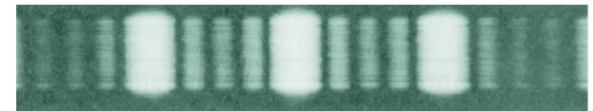
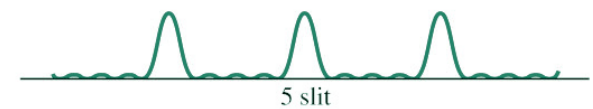
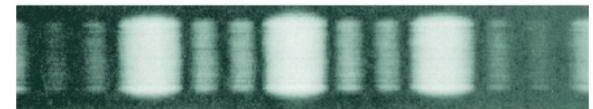
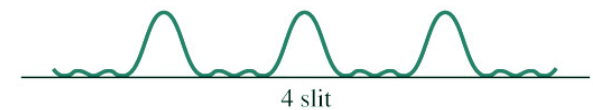
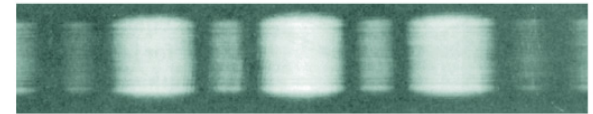
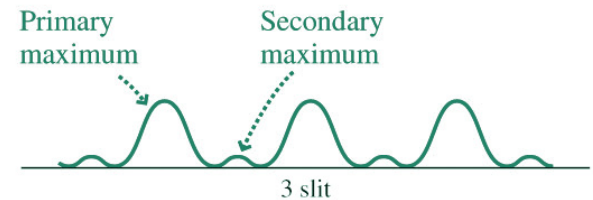
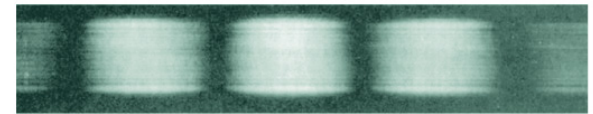
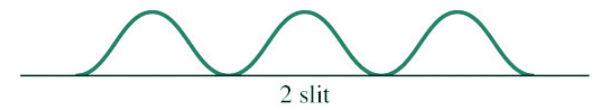


Multiple-Slit Interference

- For three or more slits, the condition for constructive interference remains the same as with two slits, namely

$$d \sin \theta_{\text{bright}} = m\lambda$$

- As the number of slits increases, the intensity maxima become higher and narrower.
- The intervening regions, which consist of minima interspersed with secondary maxima, become more uniformly dark in contrast with the bright maxima.
- With a very large number of slits, the interference pattern becomes a set of very bright, narrow lines at the primary maxima, with dark regions between.

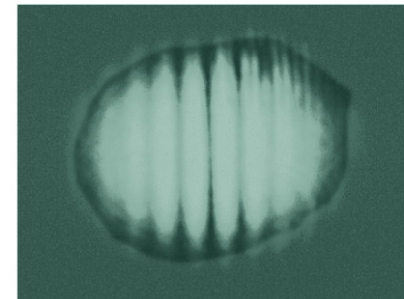
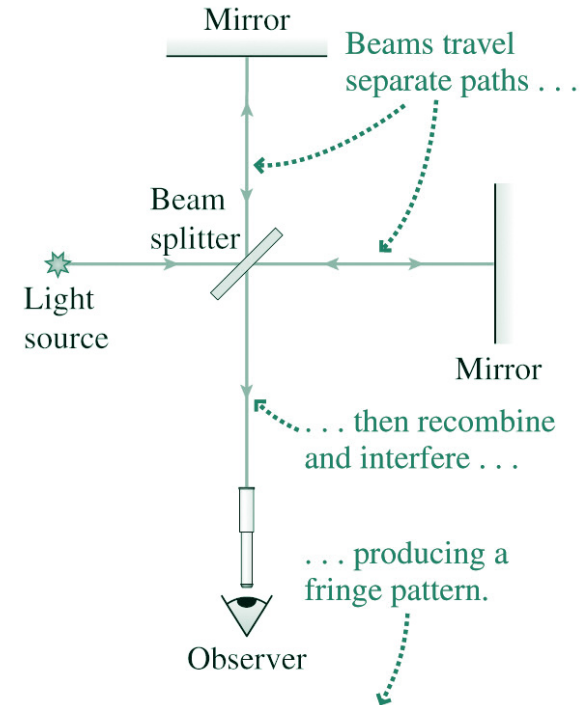


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The Michelson Interferometer

- The **Michelson interferometer** uses interference to make very precise measurements of distance, wavelength, and other quantities.
 - The device was developed by A. A. Michelson in the 1880s for the famous Michelson-Morley experiment (more in the next chapter).
 - Michelson's design is still in widespread use for precision measurements in science and technology.
 - The interferometer splits a beam of light, sends it traveling on two perpendicular paths, and recombines the beams to produce an interference pattern.
 - Details of the pattern depend on the difference in travel times for light on the two paths.

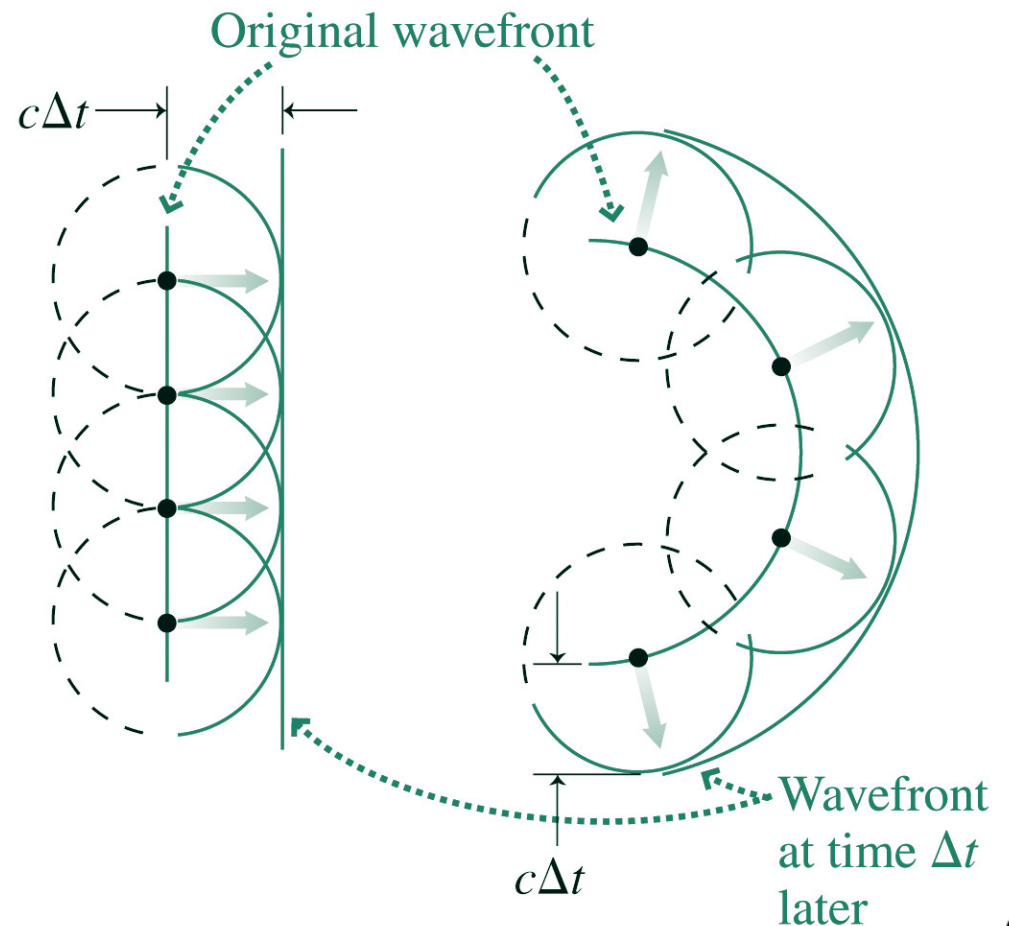
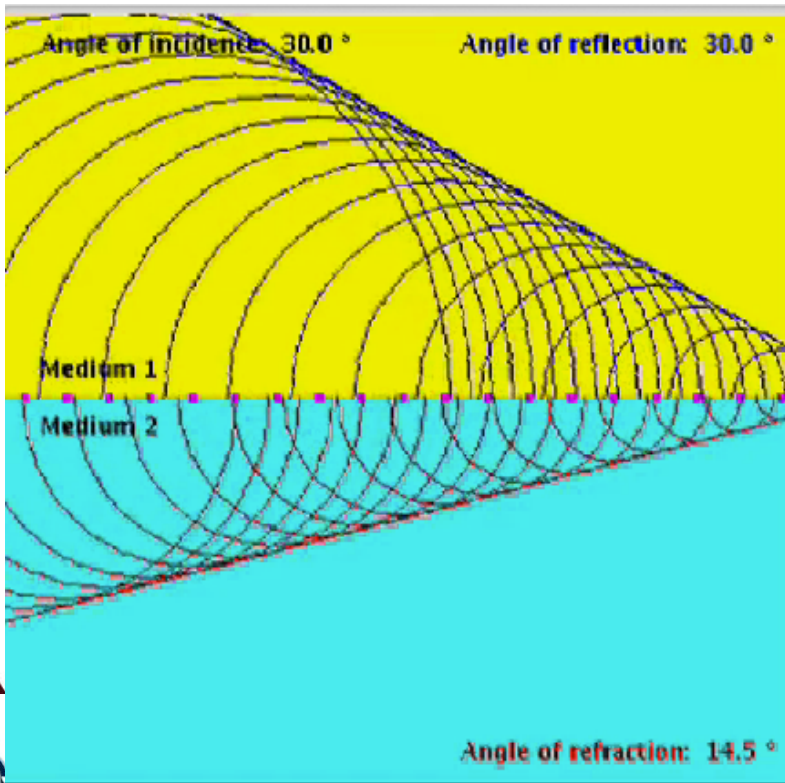


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Huygens' Principle

- **Huygens' principle** states that all points on a wavefront act as point sources of spherically propagating “wavelets” that travel at the speed of light appropriate to the medium. At a short time later, the new wavefront is the unique surface tangent to all the forward-propagating wavelets.



Huygens' Principle Movie

Angle of incidence: 30.0° Angle of reflection: 30.0°

Medium 1

Medium 2

Angle of refraction: 14.5°

Restart

Next step

Pause / Resume

1st index of refraction: 1.0

2nd index of refraction: 1.0

Angle of incidence: 30.0°

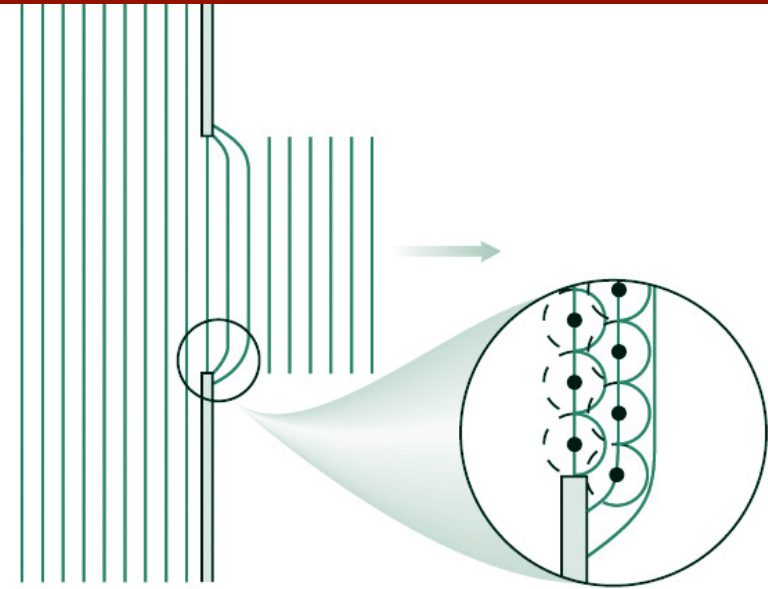
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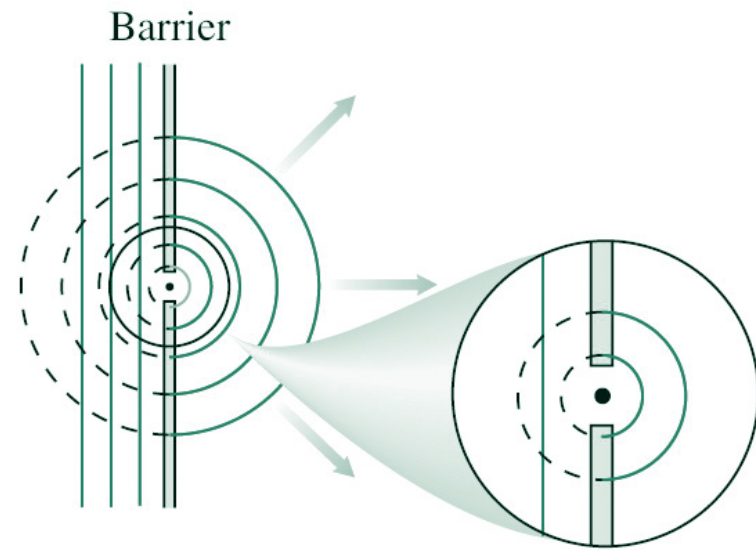


Diffraction

- **Diffraction** is the bending of waves as they pass around objects or through apertures.
 - Huygens' wavelets produced near each barrier edge cause the wavefronts to diffract, or bend at the barrier.
 - Diffraction is most notable when the size of objects is comparable to or smaller than the wavelength.

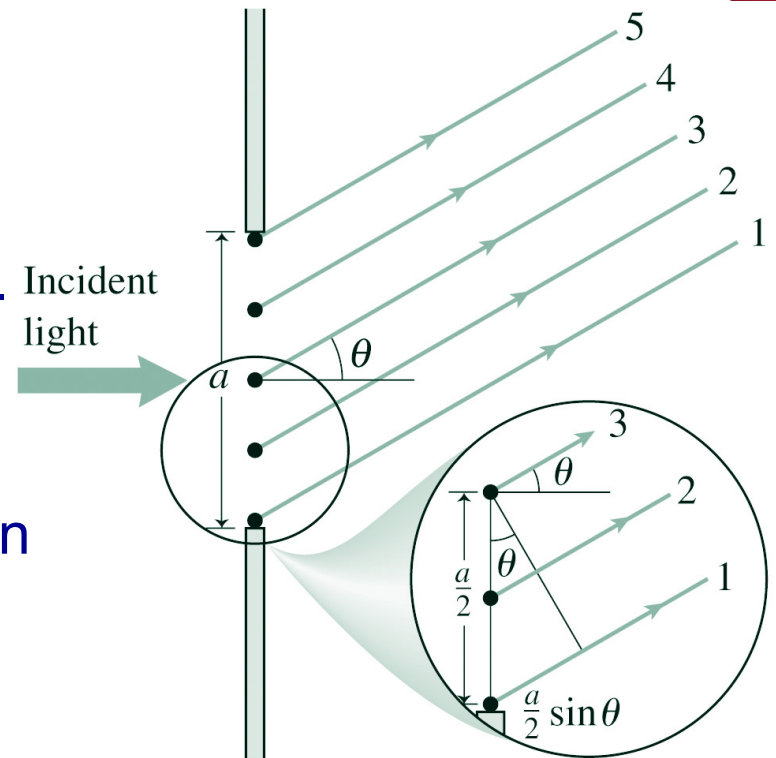


(a)

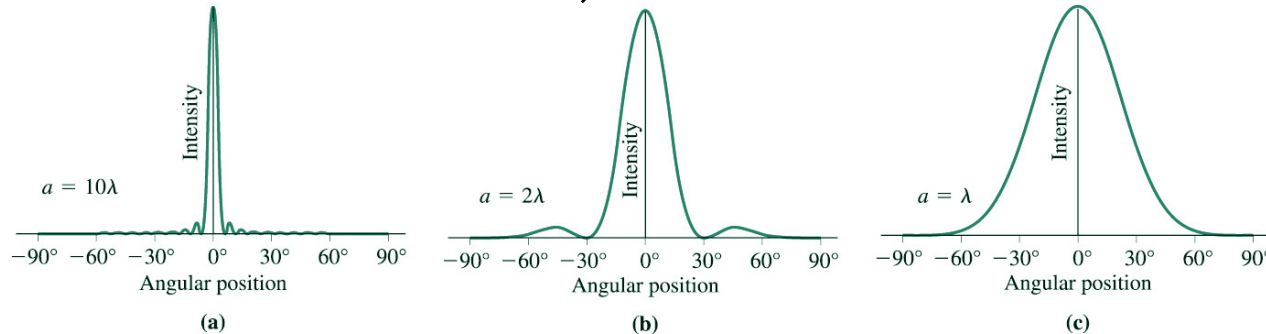


Single-Slit Diffraction

- Each point within a slit acts like a source of circular waves.
 - These waves interfere to produce a **diffraction pattern** from a single slit.
 - Intensity minima occur where
$$a \sin \theta = m\lambda$$
 - Again, this is really just an expression of a difference in path length being a multiple number of wavelengths

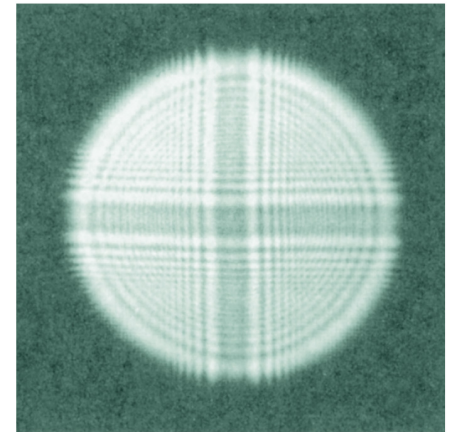
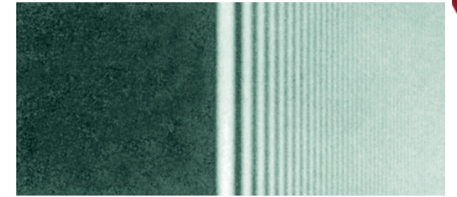


- As the slit width decreases, the central maximum widens.

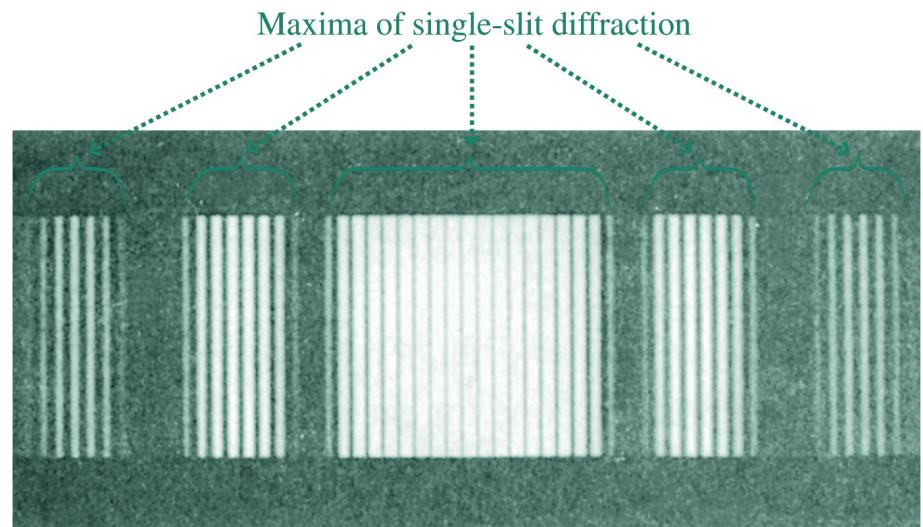


Examples of Diffraction Patterns

- Diffraction at a sharp edge:
- Diffraction through a circular aperture with crosshairs:
- Two-slit interference combined with diffraction through the individual slits:



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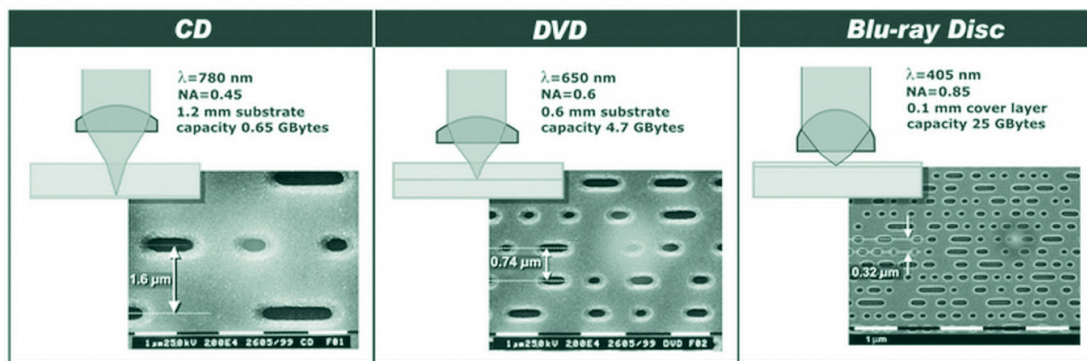


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Applications of the Diffraction Limit

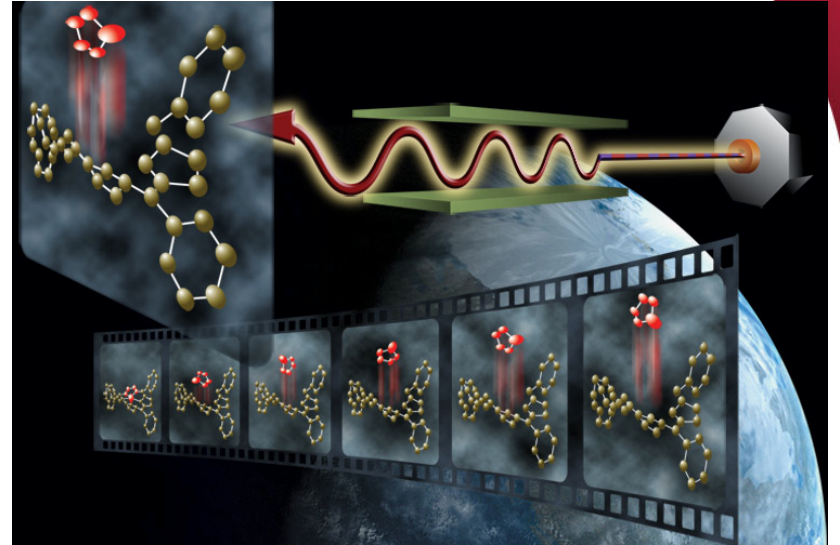
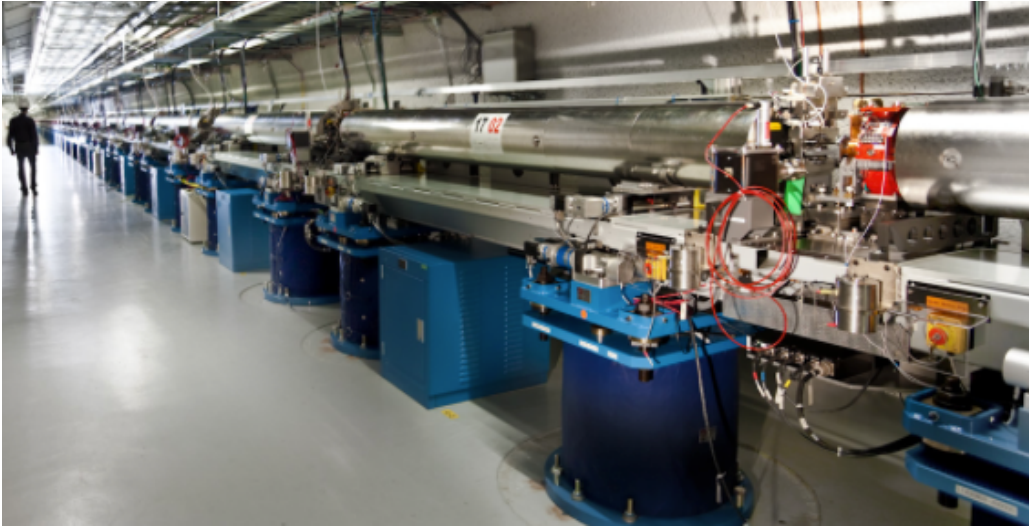
- The diffraction limit makes it impossible for microscopes to resolve objects smaller than the wavelength of the light used.
 - Ultraviolet light or high-energy electrons have short wavelengths, allowing microscopy of smaller objects than is possible with visible light.
- The diffraction limit makes it impossible for telescopes to resolve closely spaced objects, or to see details of distant objects.
 - The larger the telescope aperture, the better the resolution.
 - Atmospheric turbulence, not diffraction, limits most ground-based telescopes.
- The diffraction limits the “pit” size and therefore determines the amount of information storage on optical discs.



- CDs use infrared lasers.
- DVDs use red lasers, have smaller “pits,” and hold more information.
- HD-DVDs and Blu-ray discs use violet lasers and hold still more.



Accelerator Light and LCLS-II



- LCLS-II: Linac Coherent Light Source at SLAC (Stanford, CA)
 - Ultra-intense, short-pulse X-ray laser beams
 - Over 10^{20} times brighter than conventional lasers
 - λ down to ~ 0.075 nm, pulse time $\sim 10^{-13}$ s: can image *individual atoms*
 - Series of fast pulses => molecular movies
 - A “free electron” laser
 - generated by wiggling high energy electron beams in a very strong oscillating magnetic field in a large (2+ miles) particle accelerator

